



# BOWEN PENG

## 彭渤文

College of Electronic Science and Technology, National University of Defense Technology

✉ Changsha, China   ✉ pbow16@nudt.edu.cn   ☎ (+86) 132-1919-0118   🌐 scenarri

## 🎓 EDUCATION

**National University of Defense Technology (NUDT), Changsha, China** 2023.02 – Present

*Ph.D Candidate* in Information & Communication Engineering

Supervised by Prof. [Xiang Li](#) and Prof. [Li Liu](#)

Research interests: Adversarial machine learning and foundation models for earth vision

**NUDT, Changsha, China** 2020.09 – 2022.12

*M. Eng.* in Electronic Information

Supervised by Prof. Shaowei Yong, Associate Prof. Bo Peng, and Prof. Li Liu

Thesis: Research on Adversarial Attack Algorithms for Intelligent Recognition of Radar Targets [\[Link\]](#)

**NUDT, Changsha, China** 2016.09 – 2020.06

*B. Eng.* in Communication Engineering

## 📄 PUBLICATIONS

- [1] Towards Assessing the Synthetic-to-Measured Adversarial Vulnerability of SAR ATR. **Bowen Peng, Bo Peng, Jingyuan Xia, Tianpeng Liu, Yongxiang Liu\***, In submission, 2023 [\[Link\]](#)[\[Code\]](#)
- [2] Learning Invariant Representation via Contrastive Feature Alignment for Clutter Robust SAR Target Recognition. **Bowen Peng, Jianyue Xie, Bo Peng\*, Li Liu, IEEE GRSL**, 2023 [\[Link\]](#)
- [3] Scattering Model Guided Adversarial Examples for SAR Target Recognition: Attack and Defense. **Bowen Peng, Bo Peng\*, Jie Zhou, Jianyue Xie, Li Liu\*, IEEE TGRS**, 2022 [\[Link\]](#)[\[Code\]](#)
- [4] Speckle-Variant Attack: Toward Transferable Adversarial Attack to SAR Target Recognition. **Bowen Peng, Bo Peng\*, Jie Zhou, Jingyuan Xia, Li Liu, IEEE GRSL**, 2022 [\[Link\]](#)[\[Code\]](#)
- [5] An Empirical Study of Fully Black-Box and Universal Adversarial Attack for SAR Target Recognition. **Bowen Peng, Bo Peng\*, Shaowei Yong, Li Liu, Remote Sensing**, 2022 [\[Link\]](#)

## ♡ SERVICES

I currently serve as a voluntary reviewer for **IEEE TGRS/TIP/TCSVT**.

## 🏆 HONORS AND AWARDS

The Excellent Master's Thesis Incentive Award of the Chinese Institute of Electronics, 2023